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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/023,667	12/21/2001	Takashi Iizuka	P21408	6315
7055	7590 01/24/2003			
GREENBLUM & BERNSTEIN, P.L.C.			EXAMINER	
.,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	50 ROLAND CLARKE PLACE STON, VA 20191		ALLEN, DENISE S	
			ART UNIT	PAPER NUMBER
			2872	
			DATE MAILED: 01/24/2003	

Please find below and/or attached an Office communication concerning this application or proceeding.

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		Application No.	Applicant(s)
	Office Action Summer	10/023,667	IIZUKA, TAKASHI
'	Office Action Summary	Examiner	Art Unit
		Denise S Allen	2872
Period fo	The MAILING DATE of this communication apport	pears on the cover sheet with the c	orrespondence address
I HE I - Exter after - If the - If NO - Failur - Any r	ORTENED STATUTORY PERIOD FOR REPL'MAILING DATE OF THIS COMMUNICATION. nsions of time may be available under the provisions of 37 CFR 1.1 SIX (6) MONTHS from the mailing date of this communication. period for reply specified above is less than thirty (30) days, a reply period for reply is specified above, the maximum statutory period or re to reply within the set or extended period for reply will, by statute eply received by the Office later than three months after the mailing ad patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be tim y within the statutory minimum of thirty (30) days will apply and will expire SIX (6) MONTHS from to	s will be considered timely. the mailing date of this communication.
1)	Responsive to communication(s) filed on	·	
2a) <u></u> □		is action is non-final.	
3)□ Dispositi	Since this application is in condition for allowationsed in accordance with the practice under on of Claims	ance except for formal matters, pro	osecution as to the merits is 53 O.G. 213.
4)⊠	Claim(s) <u>1-8</u> is/are pending in the application.		
	4a) Of the above claim(s) is/are withdray	vn from consideration.	
	Claim(s) is/are allowed.		
	Claim(s) <u>1-8</u> is/are rejected.		
	Claim(s) is/are objected to.		
	Claim(s) are subject to restriction and/or	· election requirement	
	on Papers	orden of the control	
9)⊠ Т	he specification is objected to by the Examiner		
10)⊠ T	he drawing(s) filed on <u>21 December 2001</u> is/ar	e: a)⊠ accepted or b)⊡ objected to	by the Examiner.
	Applicant may not request that any objection to the	drawing(s) be held in abeyance. See	e 37 CFR 1.85(a).
11)∐ T	he proposed drawing correction filed on	is: a) ☐ approved b) ☐ disapprov	ed by the Examiner.
	If approved, corrected drawings are required in rep	ly to this Office action.	
12)∐ T	he oath or declaration is objected to by the Exa	aminer.	
Priority u	nder 35 U.S.C. §§ 119 and 120		
13)🛛 🗸	Acknowledgment is made of a claim for foreign	priority under 35 U.S.C. § 119(a)-	-(d) or (f).
a)[∑	∄ All b) ☐ Some * c) ☐ None of:		
•	 Certified copies of the priority documents 	have been received.	
2	2. Certified copies of the priority documents	have been received in Application	n No
	B. Copies of the certified copies of the priori application from the International Burde the attached detailed Office action for a list of	eau (PCT Rule 17.2(a)).	Ü
	knowledgment is made of a claim for domestic		
a)	☐ The translation of the foreign language proveknowledgment is made of a claim for domestic	risional application has been recei	ved.
Attachment(
2) Notice	of References Cited (PTO-892) of Draftsperson's Patent Drawing Review (PTO-948) ation Disclosure Statement(s) (PTO-1449) Paper No(s) 4.	4) Interview Summary (F 5) Notice of Informal Pat 6) Other:	PTO-413) Paper No(s) tent Application (PTO-152)
S. Patent and Trad TO-326 (Rev.		on Summary	Part of Paper No. 5

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DETAILED ACTION

Specification

The disclosure is objected to because of the following informalities: the phrase "when they area incident on the light receiving element" (page 14 lines 2-3) is unclear. Suggested correction: replace the word "area" with "are".

Appropriate correction is required.

Claim Objections

Claims 5 and 6 are objected to because of the following informalities: the limitation "refractive lens" (claim 5 lines 3 and 7, claim 6 line 3) is unclear because it is not certain whether or not this limitation refers to the previously recited "refractive lens element". Suggested correction: replace the limitation "refractive lens" with "refractive lens element". Appropriate correction is required.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1 - 3, 7, and 8 are rejected under 35 U.S.C. 102(b) as being anticipated by Ishikawa.

Regarding claim 1, Ishikawa teaches a scanning optical system (Figures 1 and 2) used for exposing a predetermined imaging area (column 4 lines 9 - 13) on a surface (reference A) to be scanned to a plurality of laser beams (column 4 lines 4 - 8), comprising: a plurality of light

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sources (references 12 and 14) that emit a plurality of laser beams (references 12a and 14a) having different wavelengths (column 4 lines 43 – 51), respectively; a single deflector (reference 20) which deflects the plurality of laser beams simultaneously (references 12a, 14a, and L); an imaging optical system (references 22, 24, 26, and 52) that converges the plurality of laser beams deflected by said single deflector on the surface to be scanned (column 6 lines 14 – 25 and 31 – 34); and a beam detector (reference 56) that receives the plurality of laser beams directed to outside of the predetermined imaging area via at least one of lens elements (references 22 and 52) included in said imaging optical system, a synchronizing signal being generated upon detection of each of the plurality of light beams by said beam detector (column 6 lines 26 – 30), an optical characteristic of said imaging optical system being configured such that the laser beams directed to said predetermined imaging area are aligned in a scanning direction (column 6 lines 42 – 59 and Figure 3a), while the laser beams directed to said beam detector are shifted in the scanning direction (which do not intersect reference 26 and are not adjusted).

Regarding claim 2, Ishikawa teaches said single deflector (reference 20) comprises a polygonal mirror having a plurality of reflecting surfaces (column 4 lines 55 - 56), one of said plurality of reflecting surfaces reflecting the plurality of laser beams at each scan (column 6 lines 4 - 9), said polygonal mirror being rotated so that the laser beams reflected by said reflecting surface scan.

Regarding claim 3, Ishikawa teaches said beam detector comprises a single light receiving element (reference 56), each of the plurality of laser beams being incident on said single light receiving element (column 6 lines 26 - 30).

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Regarding claim 7, Ishikawa teaches a scanning optical system (Figures 1 and 2) used for exposing a predetermined imaging area (column 4 lines 9-13) on a surface (reference A) to be scanned, comprising: a plurality of light sources (references 12 and 14) that emit a plurality of laser beams (references 12a and 14a) having different wavelengths (column 4 lines 43 – 51), respectively; a single deflector (reference 20) which deflects the plurality of laser beams simultaneously (references 12a, 14a, and L); an imaging optical system (references 22, 24, 26, and 52) that converges the plurality of laser beams deflected by said single deflector on the surface to be scanned (column 6 lines 14 - 25 and 31 - 34); and a beam detector (reference 56) that receives the plurality of laser beams directed to outside of the predetermined imaging area via at least one of lens elements (references 22 and 52) included in said imaging optical system, said imaging optical system has a first range (the part of reference a that does not intersect reference 54) and a second range (the part of reference a that intersects reference 54) along a scanning direction (reference a), the laser beams directed to said imaging area passing through said first range, the laser beams directed to said beam detector passing through said second range, said imaging optical system being configured such that, within said first range, a lateral chromatic aberration of said imaging optical system being compensated for (Figure 3a), and that within said second range, a lateral chromatic aberration resides so that the plurality of laser beams are separated from each other in the scanning direction thereof.

Regarding claim 8, Ishikawa teaches an optical characteristic of said imaging optical system, within said first range, is configured such that a plurality of beam spots respectively formed by the plurality of laser beams within said imaging area are aligned in the scanning

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direction (Figure 3a), while the plurality of laser beams are incident on said beam detector at different timings.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 4 - 6 are rejected under 35 U.S.C. 103(a) as being unpatentable over Ishikawa in view of Kondo.

Regarding claim 4, Ishikawa teaches a scanning optical system as described above.

Ishikawa further teaches the imaging optical system includes at least one refractive lens element.

Ishikawa does not teach the imaging optical system also including a diffractive lens structure formed onto said refractive lens element so that said imaging optical system exhibits said optical characteristic.

Kondo teaches a scanning optical system (Figure 2a) with an imaging optical system (references 3a, 6, and 9) that includes at least one refractive lens element (reference 3a and 6) and a diffractive lens structure (reference 9) formed onto said refractive lens element (Figure 5 references 23a and 23b). It would have been obvious to one of ordinary skill in the art at the time of the invention to form the diffractive lens structure of Kondo on a refractive lens element of the imaging optical system of Ishikawa in order to reduce the chromatic aberration of the imaging optical system (Kondo column 2 lines 31 – 51).

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Regarding claim 5, Kondo teaches the diffractive lens structure is formed in a predetermined area on a surface of a refractive lens (Figure 3b).

Regarding claim 6, Kondo teaches the diffractive lens compensates for a lateral chromatic aberration of at least on refractive lens element (column 2 lines 47 - 49).

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Denise S Allen whose telephone number is (703) 305-7407. The examiner can normally be reached on Monday - Friday, 8:30am - 5:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Cassandra Spyrou can be reached on (703) 308-1687. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 872-9318 for regular communications and (703) 872-9319 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-1782.

(*)))(*

January 21, 2003

Denise S Allen Examiner Art Unit 2872

Audrey Chang Primary Examiner Technology Center 2800